Search Notes

App	licatio	n/Con	trol N	lo.

10/649,936 Examiner

Jerry Zhu

Applicant(s)/Patent under Reexamination

HAYASHI ET AL.

Art Unit

2129

SEARCHED					
Class	Subclass	Date	Examiner		
706	13	4/28/2005	JZ		
716	9	4/28/2005	JZ		
700	121	4/28/2005	JZ		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	<u> </u>					
			:			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched East, IEEE, Google, ACM, and INSPEC	4/27/2005	JZ
Consulted Wilbert Starks	4/26/2005	JZ